

## IGBT4 Modules

#### **SKM 150GB12T4G**

**Target Data** 

#### **Features**

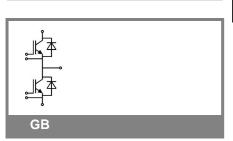
- IGBT4 = 4. Generation (Trench) IGBT
- V<sub>CEsat</sub> with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I<sub>CNOM</sub>
- Soft switching 4. Generation CAL diode (CAL4)

### **Typical Applications**

- AC inverter drives
- UPS
- Electronic welders at f<sub>sw</sub> up to 20 kHz

### Remarks

• Case temperature limited to  $T_c$  = 125°C max, recomm.  $T_{op}$  = -40 ... +150°C, product rel. results valid for  $T_i \le 150^\circ$ 



<b>Absolute Maximum Ratings</b> $T_c = 25  ^{\circ}\text{C}$ , unless otherwise specified						
Symbol	Conditions		Values	Units		
IGBT						
$V_{CES}$	T <sub>j</sub> = 25 °C		1200	V		
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>case</sub> = 25 °C	220	Α		
		T <sub>case</sub> = 80 °C	170	Α		
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>CNOM</sub>		450	Α		
$V_{\rm GES}$			± 20	V		
t <sub>psc</sub>	$V_{CC}$ = 600 V; $V_{GE} \le 15$ V; VCES < 1200 V	T <sub>j</sub> = 150 °C	10	μs		
Inverse D	iode					
I <sub>F</sub>	T <sub>j</sub> = 175 °C	$T_{case}$ = 25 °C	180	Α		
		T <sub>case</sub> = 80 °C	135	Α		
I <sub>FRM</sub>	$I_{FRM} = 3 \times I_{FNOM}$		450	Α		
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; sin.	T <sub>j</sub> = 175 °C	860	Α		
Module				•		
$I_{t(RMS)}$			500	Α		
$T_{vj}$			-40 <b>+</b> 175	°C		
T <sub>stg</sub>			-40 <b>+125</b>	°C		
V <sub>isol</sub>	AC, 1 min.		4000	V		

Characteristics $T_c =$		25 °C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_{C} = 6 \text{ mA}$		5	5,8	6,5	V
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T <sub>j</sub> = 25 °C				mA
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		0,8	0,9	V
		T <sub>j</sub> = 150 °C		0,7	0,8	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C				mΩ
		T <sub>j</sub> = 150°C				$m\Omega$
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 150 A, V <sub>GE</sub> = 15 V			1,85	2,05	V
		T <sub>j</sub> = 150°C <sub>chiplev.</sub>		2,25	2,45	V
C <sub>ies</sub>				9,3		nF
C <sub>oes</sub>	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,58		nF
C <sub>res</sub>				0,51		nF
$Q_G$	V <sub>GE</sub> = -8V /+15V			850		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			5		Ω
t <sub>d(on)</sub>						ns
t <sub>r</sub>	$R_{Gon} = \Omega$	V <sub>CC</sub> = 600V		44.0		ns
E <sub>on</sub>	$R_{Goff} = \Omega$	I <sub>Cnom</sub> = 150A T <sub>i</sub> = 150 °C		14,8		mJ ns
$egin{aligned} \mathbf{t}_{d(off)} \ \mathbf{t}_{f} \end{aligned}$	Goff 22	$V_{GE} = \pm 15V$				ns
E <sub>off</sub>		GE		14,8		mJ
R <sub>th(j-c)</sub>	per IGBT	1			0,2	K/W



# SEMITRANS<sup>®</sup> 3

### **IGBT4** Modules

#### **SKM 150GB12T4G**

**Target Data** 

#### **Features**

- IGBT4 = 4. Generation (Trench) **IGBT**
- V<sub>CEsat</sub> with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I<sub>CNOM</sub>
- Soft switching 4. Generation CAL diode (CAL4)

## **Typical Applications**

- AC inverter drives
- **UPS**
- Electronic welders at f<sub>sw</sub> up to 20 kHz

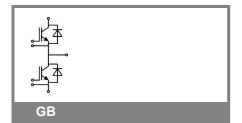
### Remarks

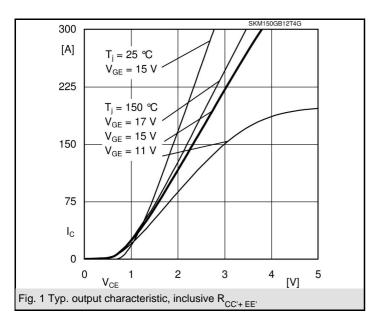
• Case temperature limited to T<sub>c</sub> = 125°C max, recomm.  $T_{op} = -40$  ... +150°C, product rel. results valid for T<sub>i</sub>≤150°

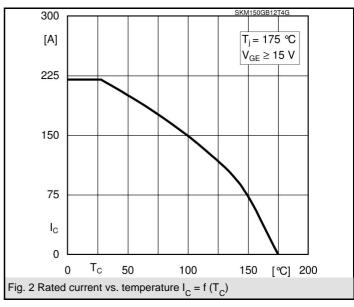
Characteristics									
Symbol	Conditions	I	min.	typ.	max.	Units			
Inverse Diode									
$V_F = V_{EC}$	$I_{Fnom} = 150 \text{ A}; V_{GE} = 0 \text{ V}$	T <sub>j</sub> = 25 °C <sub>chiplev.</sub>		2,2	2,5	V			
		$T_j = 150  ^{\circ}C_{\text{chiplev.}}$ $T_j = 25  ^{\circ}C$		2,1	2,45	V			
$V_{F0}$				1,3	1,5	V			
		$T_j = 150 ^{\circ}\text{C}$ $T_j = 25 ^{\circ}\text{C}$		0,9	1,1	V			
r <sub>F</sub>				6	6,67	mΩ			
		$T_j = 150 ^{\circ}\text{C}$ $T_j = 150 ^{\circ}\text{C}$		8	9	mΩ			
I <sub>RRM</sub>	I <sub>Fnom</sub> = 150 A	T <sub>j</sub> = 150 °C				Α			
Q <sub>rr</sub>						μC			
E <sub>rr</sub>	V <sub>GE</sub> = -15V			11,3		mJ			
R <sub>th(j-c)</sub>	per diode				0,32	K/W			
Freewheeling Diode									
$V_F = V_{EC}$	$I_{Fnom} = A; V_{GE} = V$	$T_{j} = {^{\circ}C_{chiplev}}.$ $T_{j} = {^{\circ}C}$ $T_{j} = {^{\circ}C}$ $T_{j} = {^{\circ}C}$				V			
$V_{F0}$		T <sub>j</sub> = °C				V			
r <sub>F</sub>		T <sub>j</sub> = °C				V			
I <sub>RRM</sub>	I <sub>Fnom</sub> = A	T <sub>j</sub> = °C				Α			
Q <sub>rr</sub>						μC			
E <sub>rr</sub>						mJ			
	per diode					K/W			
Module									
L <sub>CE</sub>				15	20	nΗ			
R <sub>CC'+EE'</sub>	res., terminal-chip	T <sub>case</sub> = 25 °C			0,35	mΩ			
		T <sub>case</sub> = 125 °C			0,5	mΩ			
R <sub>th(c-s)</sub>	per module			0,02	0,038	K/W			
M <sub>s</sub>	to heat sink M6		3		5	Nm			
M <sub>t</sub>	to terminals M6		2,5		5	Nm			
w					325	g			

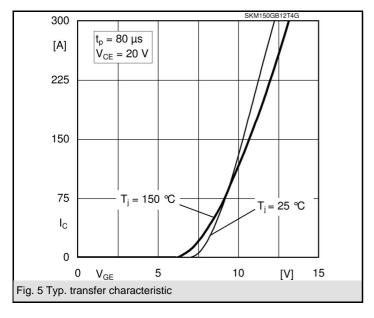
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

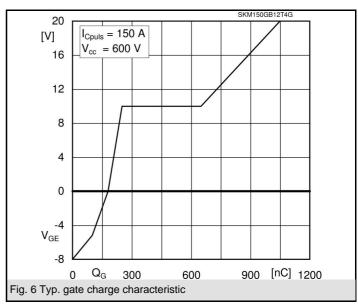
This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

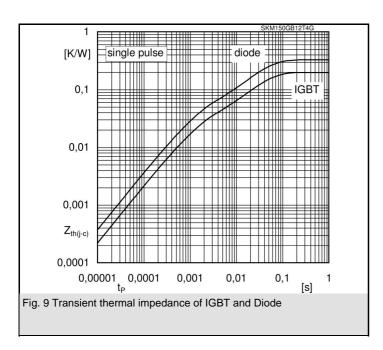


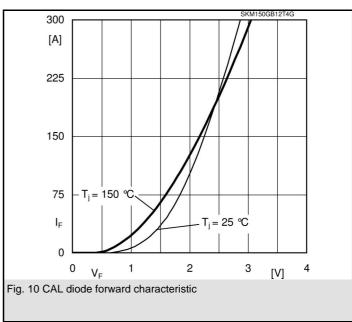


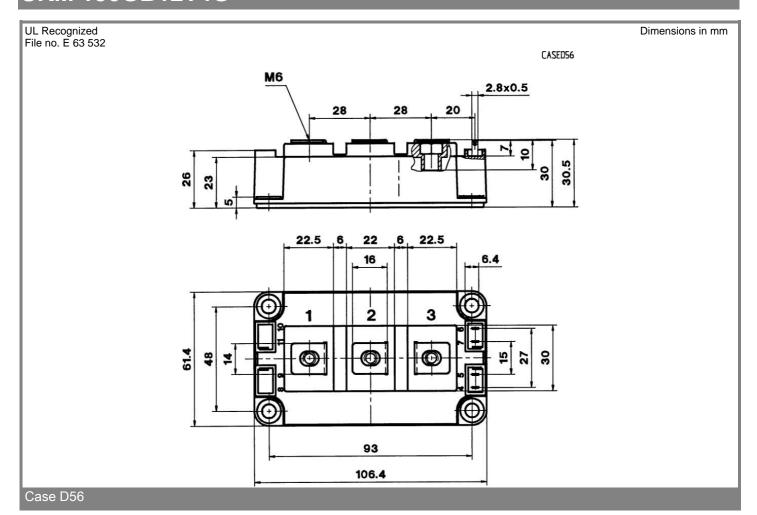


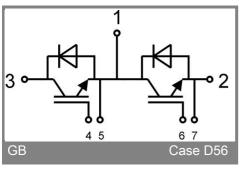












5 11-07-2007 SCH © by SEMIKRON